

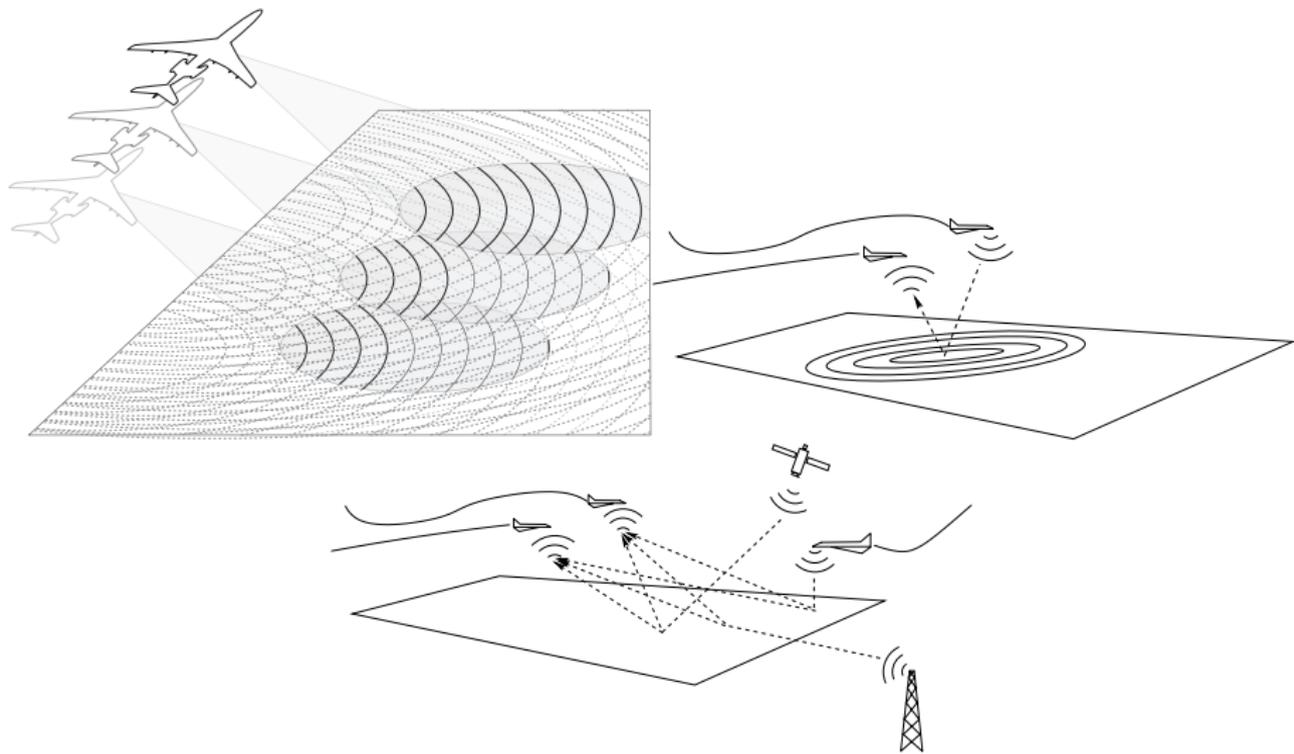
A Functional Analytic Approach to SAR Image Reconstruction

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Synthetic-Aperture Radar



SAR Data Model

- Starting from Maxwell's equations and assuming free space we find that the wave equation is a good model for EM wave propagation:

$$(\nabla^2 - c_0^{-2} \frac{\partial^2}{\partial t^2}) \mathcal{E}^{in}(t, x) = j(t, x)$$

$$(\nabla^2 - c^{-2}(x) \frac{\partial^2}{\partial t^2}) \mathcal{E}^{tot}(t, x) = j(t, x)$$

where

$$c^{-2}(x) = c_0^{-2} - T(x)$$

$$\mathcal{E}^{tot} = \mathcal{E}^{in} + \mathcal{E}^{sc}$$

- $T(x)$ is called the reflectivity function and it models the scene of interest
- We seek data of the form $d = \mathcal{F}[T]$
- Combining the two wave equations and using the Green's function for free space we obtain the Lippmann-Schwinger integral equation

$$\mathcal{E}^{sc}(t, y) = \int \int \frac{\delta(t - \tau - |y - x|/c)}{4\pi|y - x|} T(x) \partial_t^2 \mathcal{E}^{tot}(\tau, x) d\tau dx$$

SAR Data Model

- The Born approximated scattered field is given by:

$$\mathcal{E}_B^{sc}(t, y) = \int \int \frac{\delta(t - \tau - |y - x|/c)}{4\pi|y - x|} T(x) \partial_t^2 \mathcal{E}^{in}(\tau, x) d\tau dx$$

- The actual data model is written as

$$d(s, t) = \mathcal{F}[T](s, t) = \int e^{-i\omega(t - \phi(s, x))} A(x, s, \omega) T(x) dx d\omega$$

where s is the slow-time which parametrizes the antenna trajectory.

- The phase function takes on a different form depending on which SAR modality you consider:

$$\phi(s, \mathbf{x}) = r_{s, \mathbf{x}} = 2|\gamma(s) - \mathbf{x}|/c_0$$

$$\phi(s, \mathbf{x}) = r_{s, \mathbf{x}} = |\gamma_T(s) - \mathbf{x}|/c_0 + |\gamma_R(s) - \mathbf{x}|/c_0$$

$$\phi(s, \mathbf{x}) = r_{ij}(s, s', \mathbf{x}) = |\mathbf{x} - \gamma_{R_i}(s)| - |\mathbf{x} - \gamma_{R_j}(s + s')|$$

where $\gamma(s)$ is the antenna position and x is location of a scatterer.

SAR Imaging - Backprojection

- To form an image we aim to invert by applying an imaging operator \mathcal{K}

$$\begin{aligned} I(z) = \mathcal{K}[d](z) &:= \int e^{i\omega(t-\phi(s,z))} Q(z, s, \omega) d\omega d(s, t) ds dt \\ &= \int e^{-i\omega\phi(s,z)} Q(z, s, \omega) D(s, \omega) d\omega ds \\ &= \mathcal{KF}[T](z) = \int e^{i\omega(\phi(s,x)-\phi(s,z))} Q(z, s, \omega) A(x, s, \omega) d\omega ds T(x) dx \end{aligned}$$

- \mathcal{KF} is called the image-fidelity operator and is a pseudodifferential operator \Rightarrow visible singularities are preserved

Filtered backprojection

- We seek a filtered BP type reconstruction method, i.e. our image is of the form:

$$I(z) = \int e^{-2ikR_{z,s}} Q(z, s, k) D(s, k) dk ds$$

where Q is the backprojection filter and D is the 2D Fourier transform of d .

- Note our image of the form:

$$I(z) = \int K(z, x) T(x) dx$$

- K is called the point-spread function, given below:

$$K(z, x) = \int e^{-2ik(R_{z,s} - R_{x,s})} Q(z, s, k) A(x, s, k) dk ds$$

Imaging Continued

- Ideally K would be of the form:

$$\int e^{i(z-x)\cdot\xi} d\xi$$

- We perform the Stolt change of variables $(s, k) \rightarrow \xi$ where

$$\xi = \Xi(x, z, s, k) = \int_0^1 \nabla f|_{x+\mu(x-z)} d\mu$$

where $f(x) = -2kR_{x,s}$.

- After performing symbol calculus we obtain the following expression for K :

$$K \approx \int e^{i(z-x)\cdot\xi} Q(z, \xi) A(z, \xi) \eta(z, \xi) d\xi$$

- Therefore we choose Q as below:

$$Q(z, \xi) = \frac{\chi_\Omega(z, \xi)}{A(z, \xi)\eta(z, \xi)}$$

where $\chi_\Omega(z, \xi)$ is a smooth cut-off function that prevents division by zero and η is the Jacobian resulting from a Stolt change of variables.

BLUE

- We now calculate the best linear unbiased estimate of the reflectivity function from the collected data:

$$D(s, \omega) = \int e^{2ikr_{s,x}} A(\omega, s, x) T(x) dx + n(s, \omega)$$

where we assume n is zero-mean independently, identically distributed noise in s and ω , i.e. we assume

$$\begin{aligned} E[n(s, \omega)] &= 0 \\ E[n(s, \omega) \overline{n(s', \omega')}] &= \sigma^2 \delta(s - s') \delta(\omega - \omega') \end{aligned}$$

where σ^2 is the variance of the noise for a single value of s and ω and δ is the Dirac delta function.

- We aim to estimate $T(x)$ from measurements $D(s, \omega)$ via a linear estimator

$$\hat{T}(z) = \int Q(z, s, \omega) D(s, \omega) ds d\omega.$$

BLUE continued

- In BLUE we aim to minimize variance while also forcing the estimator to be unbiased.
- We seek to find the weights or filter Q such that the following functional is minimized

$$\mathcal{J}(Q) = E[|\hat{T}(z) - E[\hat{T}(z)]|^2] + \lambda(E[\hat{T}](z) - T(z))$$

- After some calculations and the Stolt change of variables the functional simplifies to

$$\begin{aligned} \mathcal{J}(Q) &= \int |Q(z, \xi)|^2 \sigma^2 \eta(z, \xi) d\xi \\ &+ \lambda \left(\int [Q(z, \xi) e^{ix \cdot \xi} A(z, \xi) \eta(z, \xi) - e^{i(x-z) \cdot \xi}] d\xi \right). \end{aligned}$$

BLUE continued

- To find the minimizer we seek Q such that the variational derivative of $\mathcal{J}(Q)$ with respect to Q is zero and that the derivative of $\mathcal{J}(Q)$ with respect to λ is also zero

$$\begin{aligned} \frac{d}{d\epsilon}(\mathcal{J}(Q + \epsilon Q_\epsilon))|_{\epsilon=0} &= 2 \operatorname{Re} \left[\int \sigma^2 Q_\epsilon(z, \xi) \overline{Q}(z, \xi) \overline{\eta}(z, \xi) d\xi \right] \\ &+ \lambda \int Q_\epsilon(z, \xi) A(z, \xi) e^{ix \cdot \xi} d\xi = 0. \end{aligned}$$

- Taking the derivative of $\mathcal{J}(Q)$ with respect to λ we obtain

$$\frac{d\mathcal{J}}{d\lambda} = \int [Q(z, \xi) e^{ix \cdot \xi} A(z, \xi) \eta(z, \xi) - e^{i(x-z) \cdot \xi}] d\xi = 0$$

which implies Q must satisfy

$$Q(z, \xi) = \frac{e^{-iz \cdot \xi}}{A(z, \xi) \eta(z, \xi)}.$$

BLUE continued

- If we insert the expression found for Q into the definition for $\widehat{T}(z)$ we obtain

$$\widehat{T}(z) = \int \frac{e^{-iz \cdot \xi}}{A(z, \xi)\eta(z, \xi)} e^{ix \cdot \xi} A(z, \xi) T(x) \eta(z, \xi) d\xi dx + \int Q(z, \xi) n(\xi) d\xi.$$

- Looking at the first term above we see that we obtain precisely the backprojected image from the previous section, i.e.

$$\widehat{T}(z) = \int e^{i(x-z) \cdot \xi} \tilde{Q}(z, \xi) \eta(z, \xi) A(z, \xi) T(x) d\xi dx + \int Q(z, \xi) n(\xi) d\xi$$

where

$$\tilde{Q}(z, \xi) = \frac{1}{A(z, \xi)\eta(z, \xi)}$$

where in this case we have assumed the data collection manifold is the entire ξ -plane.

Observations

- We first conclude that in 'ideal' circumstances we can say the backprojected image in SAR is equivalent to the BLUE of the reflectivity function.
- By 'ideal' we mean a full data collection manifold and that the imaging plane is \mathbb{R}^2 .
- In practice these 'ideal' conditions are never met and hence using these techniques do not result in a truly unbiased estimator of the reflectivity function (also there is the step when we ignore higher order terms after performing the Stolt change of variables).
- This does lead to interesting questions about how to find an unbiased estimator.

Bias

- If we return to the unbiased constraint from the BLUE calculation, note an unbiased estimator is defined by:

$$E[\hat{T}(z)] = T(z) = \int K(x, z)T(x)dx$$

- We note this requires that K is a reproducing kernel or evaluator
- The question becomes does T lie in a reproducing kernel Hilbert space and can we find a kernel such that our estimator is unbiased?

RKHS definitions and background

- **Definition.** An evaluation functional over the Hilbert space of functions \mathcal{H} is a linear functional $\mathcal{F}_t : \mathcal{H} \rightarrow \mathbb{R}$ that evaluates each function in the space at the point t , or

$$\mathcal{F}_t[f] = f(t), \quad \forall f \in \mathcal{H}.$$

- **Definition.** A Hilbert space \mathcal{H} is a reproducing kernel Hilbert space (RKHS) if the evaluation functionals are bounded, i.e. if for all t there exists some $M > 0$ such that

$$|\mathcal{F}_t[f]| = |f(t)| \leq M \|f\|_{\mathcal{H}} \quad \forall f \in \mathcal{H}.$$

- **Theorem.** If \mathcal{H} is a RKHS then for each $t \in X$ there exists a function $K_t \in \mathcal{H}$ (called the representer of t or reproducing kernel) with the reproducing property

$$\mathcal{F}_t[f] = \langle K_t, f \rangle_{\mathcal{H}} = f(t) \quad \forall f \in \mathcal{H}.$$

- Note a reproducing kernel is symmetric and positive definite. Also an RKHS defines a corresponding RK and a RK defines a unique RKHS.

SAR in an RKHS framework

- We begin by supposing the reflectivity function we wish to reconstruct lies in the Hilbert space $L^2(Y)$ where Y is the imaging plane, for simplicity say it is the rectangle $Y = \{-a \leq x \leq a, -b \leq y \leq b\}$.
- Note the inner product on this space is given by

$$\langle f(x), g(x) \rangle_{L^2(Y)} = \int_Y f(x) \overline{g(x)} dx.$$

- We also note we may express the reflectivity in terms of its Fourier transform:

$$T(x) = \frac{1}{2\pi^2} \int_{\mathbb{R}^2} e^{-ix \cdot \xi} \widehat{T}(\xi) d\xi.$$

SAR in RKHS framework continued

- We now consider the SAR data expression, and observe it is the result of a linear operator \mathcal{F} acting on T :

$$D(k, s) = \mathcal{F}[V(x)] = \int_Y e^{2ikR_{x,s}} A(x, s, k) T(x) dx$$

- The Riesz representation theorem states we may rewrite the data expression as an inner product of V with a unique element of $L^2(Y)$, i.e.

$$D(k, s) = \langle T(x), L(x; s, k) \rangle_{L^2(Y)}$$

where $L(x; s, k) = e^{-2ikR_{x,s}} \overline{A(x, s, k)}$.

SAR in RKHS framework continued

- Now consider the SAR image

$$I(z) = \int_{\Omega} Q(z, s, k) D(s, k) dsdk$$

where Q is to be determined and Ω is the data collection manifold.

- Note we may say $D \in L^2(\Omega)$, a Hilbert space, with the inner product

$$\langle D(s, k), P(s, k) \rangle_{L^2(\Omega)} = \int_{\Omega} D(s, k) \overline{P(s, k)} dsdk$$

- Now I is a linear operator acting on D and again by the Reisz representation theorem we have that

$$I(z) = \langle D(s, k), \overline{Q(z, s, k)} \rangle_{L^2(\Omega)}$$

SAR in RKHS framework continued

- Now inserting the data expression into the image we have

$$\begin{aligned} I(z) &= \langle D(s, k), \overline{Q(z, s, k)} \rangle_{L^2(\Omega)} \\ &= \langle \mathcal{F}[T(x)](s, k), \overline{Q(z, s, k)} \rangle_{L^2(\Omega)} \\ &= \langle T(x), \mathcal{F}^*[\overline{Q(z, s, k)}](x) \rangle_{L^2(\Upsilon)} \end{aligned}$$

where \mathcal{F}^* is the formal adjoint of the operator \mathcal{F} .

- We note that the formal adjoint is given by

$$\mathcal{F}^*[Q(z, s, k)](x) = \int_{\Omega} e^{-2ikR_{x,s}} \overline{A(x, s, k)} Q(z, s, k) dsdk$$

- Ideally we would have

$$\begin{aligned} I(z) &= T(z) \\ \Rightarrow I(z) &= \langle T(x), \mathcal{F}^*[\overline{Q(z, s, k)}](x) \rangle_{L^2(\Upsilon)} = T(z) \end{aligned}$$

which implies $\mathcal{F}^*[\overline{Q(z, s, k)}](x)$ should be the evaluator or reproducing kernel.

Finding the RK for $L^2(Y)$

- Now we seek the element $K_z(x) \in L^2(Y)$ such that

$$\langle T(x), K_z(x) \rangle_{L^2(Y)} = T(z)$$

- Therefore we consider the following integral equation:

$$\int_Y T(x) \overline{K_z(x)} dx = T(z)$$

which is equivalent to

$$\int_Y \left[\int_{\mathbb{R}^2} e^{-ix \cdot \xi} \hat{T}(\xi) d\xi \right] \overline{K_z(x)} dx = \int_{\mathbb{R}^2} e^{-iz \cdot \xi} \hat{T}(\xi) d\xi$$

Finding the RK for $L^2(Y)$ continued

- Rearranging the RHS we see that we require the following

$$\widehat{K_z}(\xi) = e^{-iz \cdot \xi}$$

or

$$K_z(x) = \int_{\mathbb{R}^2} e^{iz \cdot \xi} e^{-ix \cdot \xi} d\xi = \delta(z - x)$$

- We note that $\delta(z - x) \notin L^2(Y)$ as it is not bounded, hence it is not possible to find Q such that $\mathcal{F}^*[Q] = \delta(z - x)$.
- Note there are methods to obtain something 'close' to the delta function, i.e. the microlocal technique of Cheney and the Backus-Gilbert method.

A Different Hilbert space

- Let us now suppose that our reflectivity function lies in a different Hilbert space, say

$$H = \{T(x) \in L^2(\mathbb{R}^2) \mid \text{supp}(\widehat{T}(\xi)) \subseteq Y\}$$

with the inner product

$$\langle T(x), f(x) \rangle_H = \int_{\mathbb{R}^2} T(x) \overline{f(x)} dx$$

- Note we have

$$T(x) = \frac{1}{2\pi^2} \int_Y e^{-ix \cdot \xi} \widehat{T}(\xi) d\xi$$

- Now again we look for $K_z(x)$ such that

$$\langle T(x), K_z(x) \rangle_H = T(z)$$

A Different Hilbert space continued

- We now consider the integral equation

$$\int_{\mathbb{R}^2} \left[\int_Y e^{-ix \cdot \xi} \widehat{T}(\xi) d\xi \right] \overline{K_z(x)} dx = \int_Y e^{-iz \cdot \xi} \widehat{T}(\xi) d\xi$$

- We find that

$$\begin{aligned} K_z(x) &= \frac{1}{2\pi^2} \int_Y e^{-iz \cdot \xi} e^{ix \cdot \xi} d\xi \\ &= \frac{ab}{\pi^2} \operatorname{sinc}(a(x_1 - z_1)) \operatorname{sinc}(b(x_2 - z_2)) \end{aligned}$$

supposing Y is a rectangle.

A different Hilbert space continued

- Now considering the SAR image we have

$$\begin{aligned} I(z) &= \int_{\Omega} Q(z, s, k) D(s, k) ds dk \\ &= \langle D(s, k), \overline{Q(z, s, k)} \rangle_{L^2(\Omega)} \\ &= \langle T(x), \mathcal{F}^*[\overline{Q(z, s, k)}](x) \rangle_H \\ &= T(z) \end{aligned}$$

- Therefore we see we require

$$\mathcal{F}^*[\overline{Q(z, s, k)}](x) = \frac{ab}{\pi^2} \text{sinc}(a(x_1 - z_1)) \text{sinc}(b(x_2 - z_2))$$

Choosing Q

- We obtain the following integral equation for Q

$$\int_{\mathbb{R}^2} e^{-2ikR_{x,s}} \overline{A(x, s, k)Q(z, s, k)} \chi_{\Omega}(s, k) dsdk = \frac{1}{2\pi^2} \int_{\mathbb{R}^2} e^{-i(x-z)\cdot\xi} \text{rect}\left(\frac{\xi_1}{a}\right) \text{rect}\left(\frac{\xi_2}{b}\right) d\xi$$

where χ_{Ω} is an indicator function that is one on the data collection manifold and zero elsewhere.

- Using a technique similar to that used in backprojection, we perform the Stolt change of variables on the LHS and let $\overline{Q(z, s, k)} = e^{2ikR_{z,s}} \tilde{q}(z, s, k)$

$$\begin{aligned} & \int_{\mathbb{R}^2} e^{-i(x-z)\cdot\xi} \overline{A(x, \xi)} \tilde{q}(z, \xi) \chi_{\Omega}(\xi) \eta(x, z, \xi) d\xi \\ &= \frac{1}{2\pi^2} \int_{\mathbb{R}^2} e^{-i(x-z)\cdot\xi} \text{rect}\left(\frac{\xi_1}{a}\right) \text{rect}\left(\frac{\xi_2}{b}\right) d\xi \end{aligned}$$

Choosing Q continued

- Using symbol calculus we may say the LHS of above is equivalent to the LHS of below plus higher order terms

$$\begin{aligned} & \int e^{-i(x-z)\cdot\xi} \overline{A(z, \xi)} \tilde{q}(z, \xi) \chi_{\Omega}(\xi) \eta(z, z, \xi) d\xi \\ &= \frac{1}{2\pi^2} \int_{\mathbb{R}^2} e^{-i(x-z)\cdot\xi} \operatorname{rect}\left(\frac{\xi_1}{a}\right) \operatorname{rect}\left(\frac{\xi_2}{b}\right) d\xi \end{aligned}$$

- This implies we may choose \tilde{q} to be

$$\tilde{q}(z, \xi) = \frac{\operatorname{rect}\left(\frac{\xi_1}{a}\right) \operatorname{rect}\left(\frac{\xi_2}{b}\right)}{A(z, \xi) \eta(z, z, \xi) \chi_{\Omega}(\xi)}$$

Further questions

- We see that the original filter Q is therefore given by:

$$Q(z, \xi) = e^{-z \cdot \xi} \frac{\text{rect}\left(\frac{\xi_1}{a}\right) \text{rect}\left(\frac{\xi_2}{b}\right)}{A(z, \xi) \eta(z, z, \xi) \chi_{\Omega}(\xi)}$$

- We note this Q is still approximate because of our use of the symbol calculus to find only the first order term
- Also note that typically a, b or the support of the Fourier transform of the reflectivity function are unknown so actually implementing this filter in practice is not possible.
- Question: is there a RKHS that contains $T(x)$ for most scenarios in which we can find Q such that are image is exact, i.e. unbiased?

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